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Space charge dynamics in CdZnTeSe radiation detectors

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Motivation

- Cadmium zinc telluride selenide (CZTS) is room-temperature semiconducting material suitable for direct conversion of x-rays and gamma rays into electrical signals
- Selenium is found to be a very effective in reducing complications in cadmium zinc telluride (CZT) such as Te inclusions or precipitates which decreases yield and result in high cost of high-quality CZT radiation detectors
- Deep levels are responsible for charge trapping and space charge formation which decreases detector performance
- Study of space charge dynamics and deep levels is critical for improving charge collection efficiency of radiation detectors

Laser Induced Transient Current Technique (L-TCT)

- Based on measuring the current response of the detector to a laser pulse
- Allows to characterize the charge transport (mobility, lifetime, electric field profile)
- Bias polarity selects which carrier type drift thought detector



Experimental results

- In this study a semi-insulating p-type Cd_{0.9}Zn_{0.1}Te_{0.96}Se_{0.04} sample is used
- L-TCT is combined with pulsed bias to study space charge dynamics

Synchronization of laser pulse and bias pulse Pulsing period 1 s Bias Bias pulse width Depolarization time 200 ms 800 ms Laser pulse delay Bias pulse Laser pulse delay Laser pulse width 0.5 ns time

- Without bias the detector is neutral without any space charge
- Space charge formation starts after bias application
- Changing the laser pulse delay allows study of space charge dynamics
- Space charge can be eliminated using pulsed bias and then effects of space charge can be distinguished from effects of traps

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Monte Carlo Simulation

Free

carrier Trapped

carrier

ᆂ

x = L Position

- 1D numerical simulation of charge transport in semiconductor detector
- Combined with numerical solution of driftdiffusion equation and Poisson's equation
- allows study of charge transport and space charge dynamics

Detector

 $t = t_k$

Time evolution

t = 0

x = 0

Bias

Carrier density









Monte Carlo simulations - electrons

Space charge dynamics

- Three defect levels are sufficient to describe all observed effects
- Positive space charge forms due to hole injection from anode combined with recombination level near Fermi level
- Shallow levels do not contribute to space charge





Evaluated parameters

- Same experiment was measured with positive bias for holes
- Identical electric field profile is obtained

• Evaluated parameters are:

- Electron mobility $\mu_e = 830 \text{ cm}^2/\text{Vs}$
- Hole mobility $\mu_h = 40 \text{ cm}^2/\text{Vs}$
- Electron lifetime $\tau_e = 2.3 \ \mu s$
- Hole lifetime $\tau_h = 3.6 \,\mu s$
- Three defect levels:

Band diagram



Hole-current waveforms



Electric field profile



Conclusion

- CZTS semiconductor has good electron- and hole-transport properties, and single crystals are suitable for x-ray and gamma-ray detector fabrication
- Transient current technique combined with pulsed bias allow to observe charge transport and space charge dynamics inside detector
- The improvement of the crystal growth technology to suppress the recombination level is recommended

More details in: J. Pipek, M. Betušiak, E. Belas, R. Grill, P. Praus, A. Musiienko, J. Pekarek, U. N. Roy, and R. B. James, **Charge Transport and Space-Charge Formation in Cd1–xZnxTe1–ySey Radiation Detectors**, Phys. Rev. Appl. 15, (2021), doi: 10.1103/physrevapplied.15.054058.

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Thank you for your attention